

<b>Notice of References Cited</b>	Application/Control No. 10/022,144		Applicant(s)/Patent Under Reexamination NARVANEN ET AL.	
	Examiner Raj K. Jain		Art Unit 2616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,687,252 B1	02-2004	Bertrand et al.	370/401
*	B	US-6,741,853 B1	05-2004	Jiang et al.	455/418
*	C	US-5,949,775 A	09-1999	Rautiola et al.	370/338
*	D	US-6,442,401	08-2002	Behan, Paul	455/552.1
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.